

TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC74VCXHR162245FT

Low-Voltage 16-Bit Bus Transceiver with Bushold

The TC74VCXHR162245FT is a high-performance CMOS 16-bit bus transceiver. Designed for use in 1.8-V, 2.5-V or 3.3-V systems, it achieves high-speed operation while maintaining the CMOS low power dissipation.

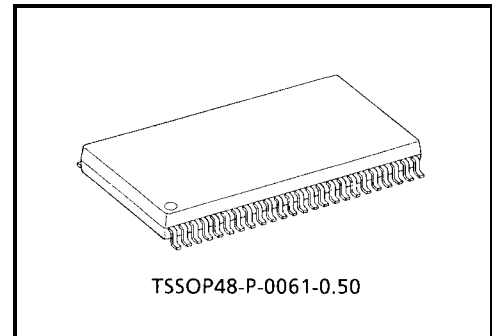
This 16-bit bus transceiver is controlled by direction control (DIR) inputs and output enable (\overline{OE}) inputs which are common to each byte. It can be used as two 8-bit transceivers or one 16-bit transceiver. The direction of data transmission is determined by the level of the DIR inputs. The \overline{OE} inputs can be used to disable the device so that the busses are effectively isolated.

The 26- Ω series resistor helps reducing output overshoot and undershoot without external resistor.

The A, B data inputs include active bushold circuitry,

eliminating the need for external pull-up resistors to hold unused or floating data inputs at a valid logic level.

All inputs are equipped with protection circuits against static discharge.



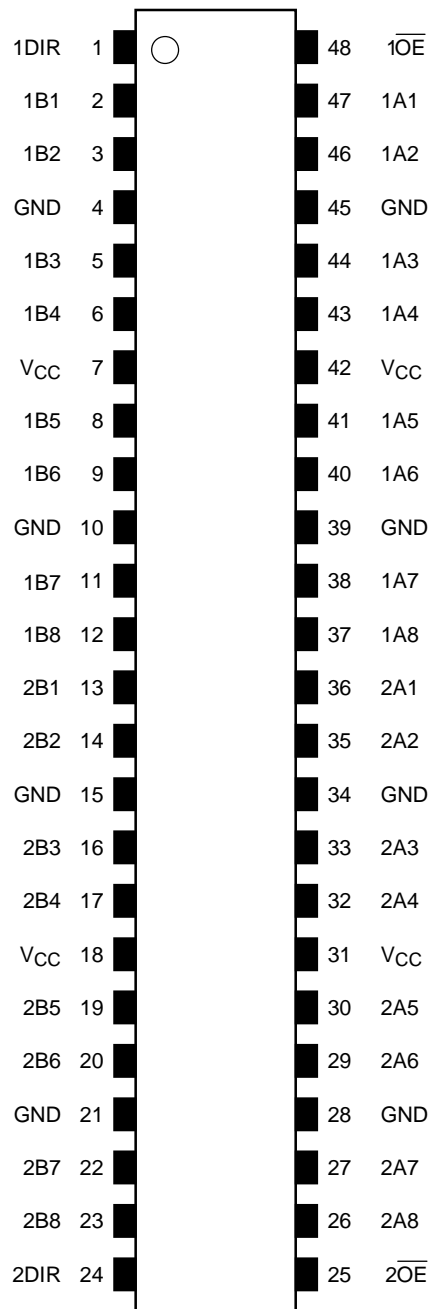
Weight: 0.25 g (typ.)

Features

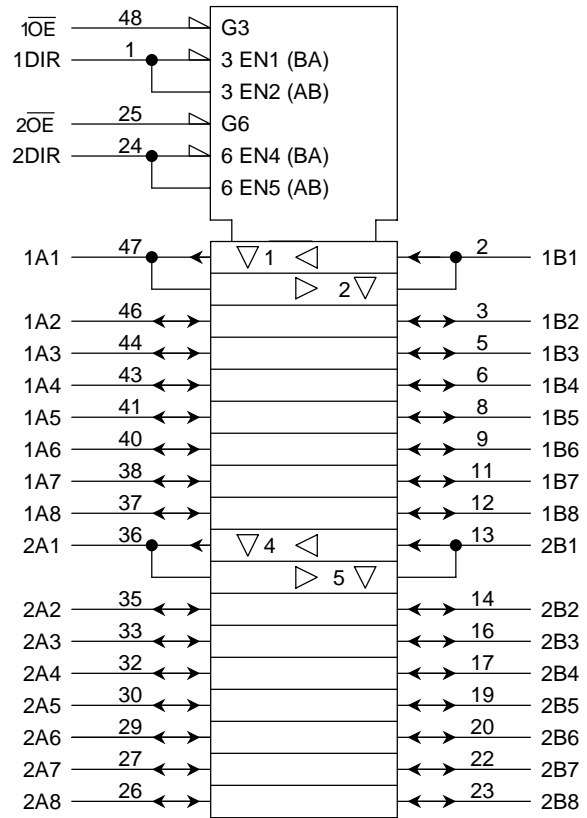
- 26- Ω series resistors on all outputs
- Low-voltage operation: $V_{CC} = 1.8$ to 3.6 V
- Bushold on data inputs eliminating the need for external pull-up/pull-down resistors
- High-speed operation: $t_{pd} = 3.4$ ns (max) ($V_{CC} = 3.0$ to 3.6 V)
 : $t_{pd} = 4.3$ ns (max) ($V_{CC} = 2.3$ to 2.7 V)
 : $t_{pd} = 5.7$ ns (max) ($V_{CC} = 1.8$ V)
- 3.6-V tolerant control inputs.
- Output current: $I_{OH}/I_{OL} = \pm 12$ mA (min) ($V_{CC} = 3.0$ V)
 : $I_{OH}/I_{OL} = \pm 8$ mA (min) ($V_{CC} = 2.3$ V)
 : $I_{OH}/I_{OL} = \pm 4$ mA (min) ($V_{CC} = 1.8$ V)
- Latch-up performance: ± 300 mA
- ESD performance: Machine model $> \pm 200$ V
 : Human body model $> \pm 2000$ V
- Package: TSSOP (thin shrink small outline package)

Note 1: Do not apply a signal to any bus pins when it is in the output mode. Damage may result.

Pin Assignment (top view)



IEC Logic Symbol



Truth Table

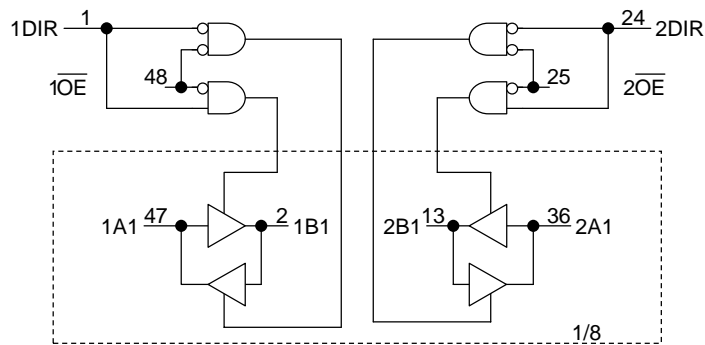
Inputs		Function		Outputs
$\overline{1OE}$	1DIR	Bus 1A1-1A8	Bus 1B1-1B8	
L	L	Output	Input	A = B
L	H	Input	Output	B = A
H	X	Z		Z

Inputs		Function		Outputs
$\overline{2OE}$	2DIR	BUS 2A1-2A8	BUS 2B1-2B8	
L	L	Output	Input	A = B
L	H	Input	Output	B = A
H	X	Z		Z

X: Don't care

Z: High impedance

System Diagram



Maximum Ratings

Characteristics	Symbol	Rating	Unit
Power supply voltage	V_{CC}	-0.5 to 4.6	V
DC input voltage	(DIR, \overline{OE})	-0.5 to 4.6	V
	(An, Bn)	-0.5 to $V_{CC} + 0.5$ (Note 2)	
DC output voltage	(An, Bn) V_{OUT}	-0.5 to $V_{CC} + 0.5$ (Note 3)	V
Input diode current	I_{IK}	-50	mA
Output diode current	I_{OK}	± 50 (Note 4)	mA
Output current	I_{OUT}	± 50	mA
Power dissipation	P_D	400	mW
DC V_{CC} /ground current per supply pin	I_{CC}/I_{GND}	± 100	mA
Storage temperature	T_{stg}	-65 to 150	$^{\circ}C$

Note 2: OFF state

Note 3: High or low state. I_{OUT} absolute maximum rating must be observed.

Note 4: $V_{OUT} < GND$, $V_{OUT} > V_{CC}$

Recommended Operating Range (Note 5)

Characteristics	Symbol	Rating	Unit
Power supply voltage	V_{CC}	1.8 to 3.6	V
		1.2 to 3.6 (Note 6)	
Input voltage	(DIR, \overline{OE})	-0.3 to 3.6	V
	(An, Bn)	0 to V_{CC} (Note 7)	
Output voltage	(An, Bn) V_{OUT}	0 to V_{CC} (Note 8)	V
Output current	I_{OH}/I_{OL}	± 12 (Note 9)	mA
		± 8 (Note 10)	
		± 4 (Note 11)	
Operating temperature	T_{opr}	-40 to 85	$^{\circ}C$
Input rise and fall time	dt/dv	0 to 10 (Note 12)	ns/V

Note 5: Floating or unused control inputs must be held high or low.

Note 6: Data retention only

Note 7: OFF state

Note 8: High or low state

Note 9: $V_{CC} = 3.0$ to 3.6 V

Note 10: $V_{CC} = 2.3$ to 2.7 V

Note 11: $V_{CC} = 1.8$ V

Note 12: $V_{IN} = 0.8$ to 2.0 V, $V_{CC} = 3.0$ V

Electrical Characteristics

DC Characteristics (Ta = -40 to 85°C, 2.7 V < VCC ≤ 3.6 V)

Characteristics		Symbol	Test Condition		VCC (V)	Min	Max	Unit
Input voltage	H-level	V _{IH}	—		2.7 to 3.6	2.0	—	V
	L-level	V _{IL}	—		2.7 to 3.6	—	0.8	
Output voltage	H-level	V _{OH}	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -100 μA	2.7 to 3.6	V _{CC} - 0.2	—	V
				I _{OH} = -6 mA	2.7	2.2	—	
				I _{OH} = -8 mA	3.0	2.4	—	
				I _{OH} = -12 mA	3.0	2.2	—	
	L-level	V _{OL}	V _{IN} = V _{IH} or V _{IL}	I _{OL} = 100 μA	2.7 to 3.6	—	0.2	
				I _{OL} = 6 mA	2.7	—	0.4	
				I _{OL} = 8 mA	3.0	—	0.5	
				I _{OL} = 12 mA	3.0	—	0.8	
Input leakage current (DIR, \overline{OE})		I _{IN}	V _{IN} = 0 to 3.6 V		2.7 to 3.6	—	±5.0	μA
Bushold input minimum drive hold current		I _{I (HOLD)}	V _{IN} = 0.8 V		3.0	75	—	μA
			V _{IN} = 2.0 V		3.0	-75	—	
Bushold input over-drive current to change state		I _{I (OD)}	(Note 13)		3.6	—	450	μA
			(Note 14)		3.6	—	-450	
3-state output OFF state current		I _{OZ}	V _{IN} = V _{IH} or V _{IL} V _{OUT} = V _{CC} or GND		2.7 to 3.6	—	±10.0	μA
Quiescent supply current		I _{CC}	V _{IN} = V _{CC} or GND		2.7 to 3.6	—	20.0	μA
Increase in I _{CC} per input		ΔI _{CC}	V _{IH} = V _{CC} - 0.6 V		2.7 to 3.6	—	750	μA

Note 13: An external driver must source at least the specified current to switch from LOW-to-HIGH.

Note 14: An external driver must sink at least the specified current to switch from HIGH-to-LOW.

DC Characteristics (Ta = -40 to 85°C, 2.3 V ≤ VCC ≤ 2.7 V)

Characteristics		Symbol	Test Condition		VCC (V)	Min	Max	Unit
Input voltage	H-level	V _{IH}	—		2.3 to 2.7	1.6	—	V
	L-level	V _{IL}	—		2.3 to 2.7	—	0.7	
Output voltage	H-level	V _{OH}	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -100 μA	2.3 to 2.7	V _{CC} - 0.2	—	V
				I _{OH} = -4 mA	2.3	2.0	—	
				I _{OH} = -6 mA	2.3	1.8	—	
	L-level	V _{OL}	V _{IN} = V _{IH} or V _{IL}	I _{OL} = 100 μA	2.3 to 2.7	—	0.2	
				I _{OL} = 6 mA	2.3	—	0.4	
				I _{OL} = 8 mA	2.3	—	0.6	
Input leakage current (DIR, \overline{OE})		I _{IN}	V _{IN} = 0 to 3.6 V		2.3 to 2.7	—	±5.0	μA
Bushold input minimum drive hold current		I _I (HOLD)	V _{IN} = 0.7 V		2.3	45	—	μA
			V _{IN} = 1.6 V		2.3	-45	—	
Bushold input over-drive current to change state		I _I (OD)	(Note 13)		2.7	—	300	μA
			(Note 14)		2.7	—	-300	
3-state output OFF state current		I _{OZ}	V _{IN} = V _{IH} or V _{IL} V _{OUT} = V _{CC} or GND		2.3 to 2.7	—	±10.0	μA
Quiescent supply current		I _{CC}	V _{IN} = V _{CC} or GND		2.3 to 2.7	—	20.0	μA

Note 13: An external driver must source at least the specified current to switch from LOW-to-HIGH.

Note 14: An external driver must sink at least the specified current to switch from HIGH-to-LOW.

DC Characteristics (Ta = -40 to 85°C, 1.8 V ≤ VCC < 2.3 V)

Characteristics		Symbol	Test Condition		VCC (V)	Min	Max	Unit
Input voltage	H-level	V _{IH}	—		1.8 to 2.3	0.7 × V _{CC}	—	V
	L-level	V _{IL}	—		1.8 to 2.3	—	0.2 × V _{CC}	
Output voltage	H-level	V _{OH}	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -100 μA	1.8	V _{CC} - 0.2	—	V
				I _{OH} = -4 mA	1.8	1.4	—	
	L-level	V _{OL}	V _{IN} = V _{IH} or V _{IL}	I _{OL} = 100 μA	1.8	—	0.2	
				I _{OL} = 4 mA	1.8	—	0.3	
Input leakage current (DIR, \overline{OE})		I _{IN}	V _{IN} = 0 to 3.6 V		1.8	—	±5.0	μA
Bushold input minimum drive hold current		I _I (HOLD)	V _{IN} = 0.36 V		1.8	25	—	μA
			V _{IN} = 1.26 V		1.8	-25	—	
Bushold input over-drive current to change state		I _I (OD)	(Note 13)		1.8	—	200	μA
			(Note 14)		1.8	—	-200	
3-state output OFF state current		I _{OZ}	V _{IN} = V _{IH} or V _{IL} V _{OUT} = V _{CC} or GND		1.8	—	±10.0	μA
Quiescent supply current		I _{CC}	V _{IN} = V _{CC} or GND		1.8	—	20.0	μA

Note 13: An external driver must source at least the specified current to switch from LOW-to-HIGH.

Note 14: An external driver must sink at least the specified current to switch from HIGH-to-LOW.

AC Characteristics (Ta = -40 to 85°C, input: t_r = t_f = 2.0 ns, C_L = 30 pF, R_L = 500 Ω)

Characteristics		Symbol	Test Condition		VCC (V)	Min	Max	Unit
Propagation delay time	t _{pLH} t _{pHL}	Figure 1, Figure 2	1.8		1.5	5.7	ns	
			2.5 ± 0.2		1.0	4.3		
			3.3 ± 0.3		0.8	3.4		
3-state output enable time	t _{pZL} t _{pZH}	Figure 1, Figure 3	1.8		1.5	7.6	ns	
			2.5 ± 0.2		1.0	5.7		
			3.3 ± 0.3		0.8	4.2		
3-state output disable time	t _{pLZ} t _{pHZ}	Figure 1, Figure 3	1.8		1.5	5.7	ns	
			2.5 ± 0.2		1.0	4.8		
			3.3 ± 0.3		0.8	4.1		
Output to output skew	t _{osLH} t _{osHL}	(Note 15)	1.8		—	0.5	ns	
			2.5 ± 0.2		—	0.5		
			3.3 ± 0.3		—	0.5		

For C_L = 50 pF, add approximately 300 ps to the AC maximum specification.

Note 15: Parameter guaranteed by design.

$$(t_{osLH} = |t_{pLHm} - t_{pLHn}|, t_{osHL} = |t_{pHLm} - t_{pHLn}|)$$

Dynamic Switching Characteristics (Ta = 25°C, input: tr = tf = 2.0 ns, CL = 30 pF)

Characteristics	Symbol	Test Condition	VCC (V)	Typ.	Unit
Quiet output maximum dynamic VOL	VOLP	V _{IH} = 1.8 V, V _{IL} = 0 V (Note 16)	1.8	0.15	V
		V _{IH} = 2.5 V, V _{IL} = 0 V (Note 16)	2.5	0.25	
		V _{IH} = 3.3 V, V _{IL} = 0 V (Note 16)	3.3	0.35	
Quiet output minimum dynamic VOL	VOLV	V _{IH} = 1.8 V, V _{IL} = 0 V (Note 16)	1.8	-0.15	V
		V _{IH} = 2.5 V, V _{IL} = 0 V (Note 16)	2.5	-0.25	
		V _{IH} = 3.3 V, V _{IL} = 0 V (Note 16)	3.3	-0.35	
Quiet output minimum dynamic VOH	VOHV	V _{IH} = 1.8 V, V _{IL} = 0 V (Note 16)	1.8	1.55	V
		V _{IH} = 2.5 V, V _{IL} = 0 V (Note 16)	2.5	2.05	
		V _{IH} = 3.3 V, V _{IL} = 0 V (Note 16)	3.3	2.65	

Note 16: Parameter guaranteed by design.

Capacitive Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	VCC (V)	Typ.	Unit
Input capacitance	C _{IN}	—	1.8, 2.5, 3.3	6	pF
Bus I/O capacitance	C _{I/O}	—	1.8, 2.5, 3.3	7	pF
Power dissipation capacitance	C _{PD}	f _{IN} = 10 MHz (Note 17)	1.8, 2.5, 3.3	20	pF

Note 17: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

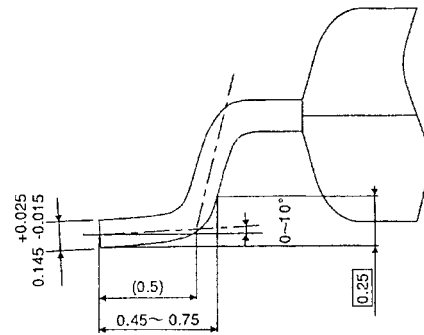
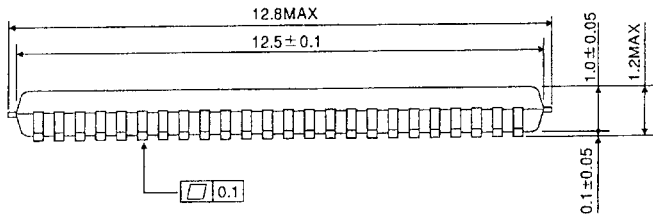
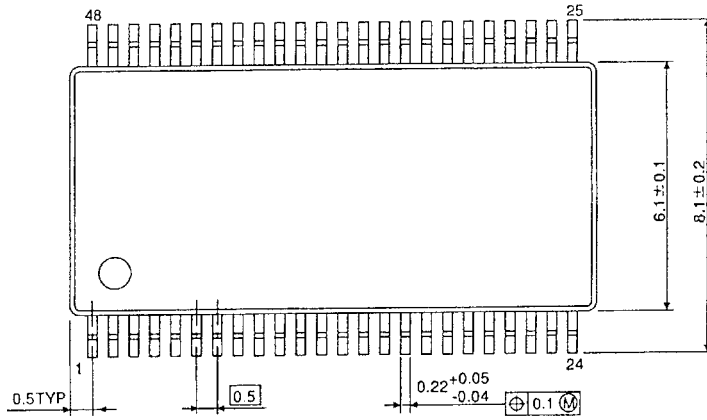
Average operating current can be obtained by the equation:

$$I_{CC(opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/16 \text{ (per bit)}$$

Package Dimensions

TSSOP48-P-0061-0.50

Unit : mm



Weight: 0.25 g (typ.)

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